

Search Notes

Application/Control No.

10/001,756

Examiner

John S. Chu

Applicant(s)/Patent under
Reexamination

BECK ET AL.

Art Unit

1752

SEARCHED

Class	Subclass	Date	Examiner
430	270.1	8/2005	<i>JSC</i>
548	440		
549	43		
549	48		
438	99		
257	40		

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST SEARCH UPDATED	8/2005	<i>JSC</i>

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner